

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10578676	TANEYA ET AL.
	Examiner	Art Unit
	MARCOS BATISTA	2617

SEARCHED

Class	Subclass	Date	Examiner
455	566	11/4/2008	mb
455	575.3	4/16/2008	mb

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with TA - Yogesh Aggarwal	4/16/2008	mb
Consulted with Lun-YI Lao	4/16/2008	mb
East Search	4/16/2008	mb
Inventor's Name Seach	4/16/2008	mb
Consulted with Rafael Perez Gutierrez	11/4/2008	mb
Consulted with Rafael Perez Gutierrez	6/15/2009	mb

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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